Search Notes

Application/Control No.	Applicant(s)/Patent under Reexamination		
10/722,265	CHANG, SHUN-HWA	CHANG, SHUN-	
Examiner	Art Unit	Art Unit	
Shih-yung Hsieh	2837	2837	

	SEARCHED					
Class	Subclass	Date	Examiner			
84	453					
	380R 384					
	384					
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	387R					
42	35	4/22/05	SWIJ			
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INT	INTERFERENCE SEARCHED		
Class	Subclass	Date	Examiner
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SEARCH NOTES (INCLUDING SEARCH STRATEGY)				
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